

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): YAMAGUCHI

Serial No.: 10/621,488

Filed: July 18, 2003

Title: SEMICONDUCTOR DEVICE INCLUDING
POWER MOSFET AND PERIPHERAL
DEVICE AND METHOD FOR
MANUFACTURING THE SAME

Atty. Dkt.: 01-116-DIV

Group Art Unit: 2811

Examiner: Unknown

Commissioner for Patents
Arlington, VA 22202

Date: February 12, 2004

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

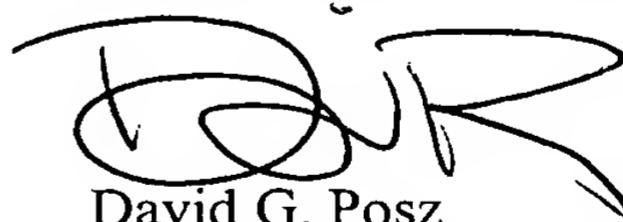
Sir:

Pursuant to 37 C.F.R. §1.56, the references listed on the attached Form PTO-1449 are being submitted for consideration by the Examiner without any admission that they constitute statutory prior art, or without any admission that they contain subject matter that anticipates the invention or renders the invention obvious to a person of ordinary skill in the art.

Further, pursuant to 37 C.F.R. §1.97(e), the undersigned hereby certifies that each listed reference was first cited in a Communication (copy enclosed) from a foreign patent office in connection with a counterpart foreign application not more than three months prior to the filing of this statement.

Although no fees are believed to be due at this time, it is respectfully requested that any such fees be charged to Deposit Account 50-1147. Also, the Examiner is requested to initial the attached PTO Form-1449 and to return a copy of same to the undersigned attorney as proof that the listed references have been considered and made of record.

Respectfully submitted,



David G. Posz
Reg. No. 37,701

Posz & Bethards, PLC
11250 Roger Bacon Drive
Suite 10
Reston, VA 20190
(703) 707-9110
Customer No. 23400

FORM PTO-1449

FEB 12 2004

O I P E
P A T E N T & T R A D E M A R K O F F I C E

ATTY. DKT NO.	01-116-DIV	SER. NO.	10/621,488
APPLICANT	YAMAGUCHI		
FILING DATE	July 18, 2003	GROUP	2811

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

FOREIGN PATENT DOCUMENTS

TRANSLATION

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
		JP-A-S58-164258	9/29/83	JAPAN				X (Abstract)	
		JP-A-H03-82138	04/08/91	JAPAN				X (Abstract)	

* Full English text of the JP Document will be available in machine-translated form from JP (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER		DATE CONSIDERED

Rev. 10/94 (Form 3.05)